

# Deutsche Akkreditierungsstelle

## Annex to the Partial Accreditation Certificate D-K-19781-01-01 according to DIN EN ISO/IEC 17025:2018

**Valid from:** 27.03.2024

**Date of issue:** 27.03.2024

This annex is a part of the accreditation certificate D-K-19781-01-00.

Holder of partial accreditation certificate:

**K. Meyer R.M.S. GmbH**  
**Gotenweg 15–17, 58119 Hagen**

with the location

**K. Meyer R.M.S. GmbH**  
**Gotenweg 15–17, 58119 Hagen**

The calibration laboratory meets the requirements of DIN EN ISO/IEC 17025:2018 to carry out the conformity assessment activities listed in this annex. The calibration laboratory meets additional legal and normative requirements, if applicable, including those in relevant sectoral schemes, provided that these are explicitly confirmed below.

The management system requirements of DIN EN ISO/IEC 17025 are written in the language relevant to the operations of calibration laboratories and they conform to the principles of DIN EN ISO 9001.

Calibration in the fields:

### **Electrical quantities**

#### **DC and low frequency quantities**

- **DC voltage**
- **DC current**
- **DC resistance**

*This certificate annex is only valid together with the written accreditation certificate and reflects the status as indicated by the date of issue. The current status of any given scope of accreditation can be found in the directory of accredited bodies maintained by Deutsche Akkreditierungsstelle GmbH at <https://www.dakks.de>.*

Abbreviations used: see last page

**Page 1 of 2**

This document is a translation. The definitive version is the original German annex to the accreditation certificate.

**Annex to the Partial Accreditation Certificate D-K-19781-01-01**

**Permanent Laboratory**

**Calibration and Measurement Capabilities (CMC)**

Measurement quantity / Calibration item	Range	Measurement conditions / procedure	Expanded uncertainty of measurement	Remarks
DC Voltage Sources and measuring instruments	0.01 V to 0.1 V		$0.1 \text{ mV} + 0.02 \cdot 10^{-3} \cdot U$	U: measured value
	> 0.1 V to 1 V		$0.1 \text{ mV} + 0.02 \cdot 10^{-3} \cdot U$	
	> 1 V to 10 V		$0.2 \text{ mV} + 0.2 \cdot 10^{-3} \cdot U$	
	> 10 V to 100 V		$0.2 \text{ mV} + 0.2 \cdot 10^{-3} \cdot U$	
DC current Sources and measuring instruments	0.01 mA to 10 mA		$0.1 \text{ mA} + 0.2 \cdot 10^{-3} \cdot I$	I: measured value
	> 10 mA to 100 mA		$0.1 \text{ mA} + 0.2 \cdot 10^{-3} \cdot I$	
DC resistance Resistors and measuring instruments	1 $\Omega$ to 4 k $\Omega$		$0.5 \cdot 10^{-3} \cdot R$	R: measured value
	> 4 k $\Omega$ to 100 k $\Omega$		$5 \cdot 10^{-3} \cdot R$	

**Abbreviations used:**

- CMC Calibration and measurement capabilities (Kalibrier- und Messmöglichkeiten)
- DIN Deutsches Institut für Normung e.V. – German institute for standardization
- EN Europäische Norm – European Standard
- IEC International Electrotechnical Commission
- ISO International Organization for Standardisation

Valid from: 27.03.2024

Date of issue: 27.03.2024

Page 2 of 2

This document is a translation. The definitive version is the original German annex to the accreditation certificate.